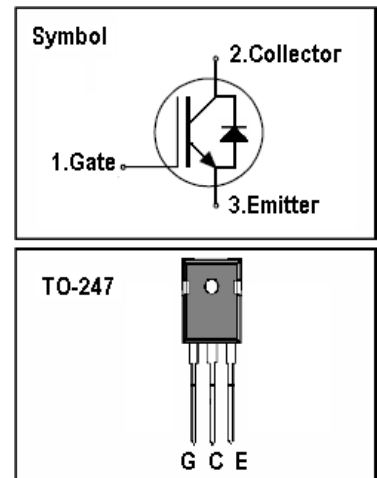


IGBT

Features

- 650V,75A
- $V_{CE(sat)(typ.)}=1.9V@V_{GE}=15V,I_C=75A$
- High speed switching
- Positive VCE(on) Temperature Coefficient
- Trench & Field Stop Technology



General Description

JIAEN FS-IGBTs offer lower losses and higher energy efficiency for application such as solar inverter、 servo drive amplifier and ups applications.

Absolute Maximum Ratings

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Continuous Collector Current ($T_C=25^\circ C$)	115	A
	Continuous Collector Current ($T_C=100^\circ C$)	75	A
I_{CM}	Pulsed Collector Current (Note 1)	225	A
I_F	Diode Continuous Forward Current ($T_C=100^\circ C$)	75	A
I_{FM}	Diode Maximum Forward Current (Note 1)	225	A
t_{sc}	Short Circuit Withstand Time ($T_j \leq 150^\circ C$)	5	us
P_D	Maximum Power Dissipation ($T_C=25^\circ C$)	375	W
	Maximum Power Dissipation ($T_C=100^\circ C$)	187	W
T_J	Operating Junction Temperature Range	-55 to +175	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Max.	Units
$R_{th\ j-c}$	Thermal Resistance, Junction to case for IGBT	0.4	$^\circ C/W$
$R_{th\ j-c}$	Thermal Resistance, Junction to case for Diode	0.42	$^\circ C/W$
$R_{th\ j-a}$	Thermal Resistance, Junction to Ambient	40	$^\circ C/W$

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_C=250\mu A$	650	-	-	V
I_{CES}	Collector-Emitter Leakage Current	$V_{CE}=650V, V_{GE}=0V$	-	-	75	μA
I_{GES}	Gate Leakage Current, Forward	$V_{GE}=30V, V_{CE}=0V$	-	-	100	nA
	Gate Leakage Current, Reverse	$V_{GE}=-30V, V_{CE}=0V$	-	-	100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_C=250\mu A$	3.2	4.0	4.8	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=75A, TC=25^\circ\text{C}$	1.50	1.90	2.40	V
		$I_C=75A, TC=125^\circ\text{C}$		2.15		
Q_g	Total Gate Charge	$V_{CC}=520V$ $V_{GE}=15V$ $I_C=75A$	-	118		nC
Q_{ge}	Gate-Emitter Charge		-	32		nC
Q_{gc}	Gate-Collector Charge		-	30		nC
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=520V$ $V_{GE}=15V$ $I_C=75A$ $R_G=15\Omega$ Inductive Load $T_C=25^\circ\text{C}$ note2	-	45	-	ns
t_r	Turn-on Rise Time		-	100	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	232	-	ns
t_f	Turn-off Fall Time		-	137	-	ns
E_{on}	Turn-on Switching Loss		-	3.56	-	mJ
E_{off}	Turn-off Switching Loss		-	4.58	-	mJ
E_{ts}	Total Switching Loss		-	8.14	-	mJ
C_{ies}	Input Capacitance	$V_{CE}=25V$	-	3780	-	pF
C_{oes}	Output Capacitance	$V_{GE}=0V$	-	356	-	pF
C_{res}	Reverse Transfer Capacitance	$f=1\text{MHz}$	-	37	-	pF

Electrical Characteristics of Diode ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_F	Diode Forward Voltage	$I_F=75A$	-	1.58	2.0	V
		$I_F=75A, TC=125^\circ\text{C}$		1.35		
t_{rr}	Diode Reverse Recovery Time	$V_{CE}=400V$	-	135		ns
I_{rr}	Diode peak Reverse Recovery Current	$I_F=75A$	-	28		A
Q_{rr}	Diode Reverse Recovery Charge	$dI_F/dt=200A/\mu s$	-	1.8		μC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. From jiaen laboratory

Typical Performance Characteristics

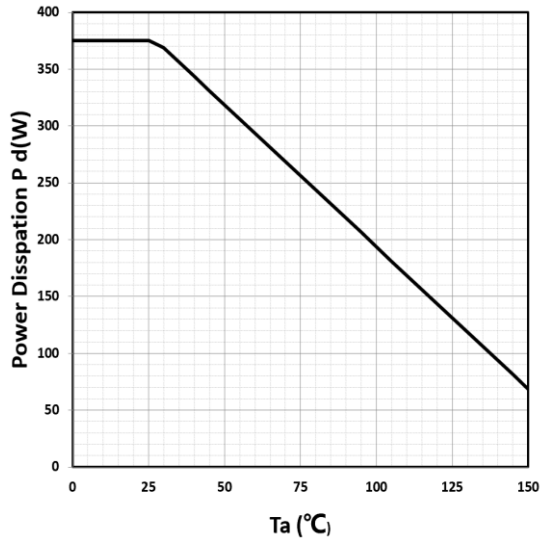


Figure1: power dissipation VS. case temperature

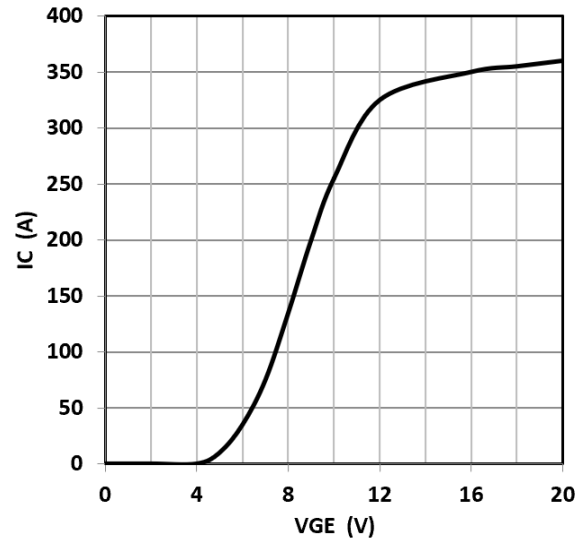


Figure2: VGE VS IC

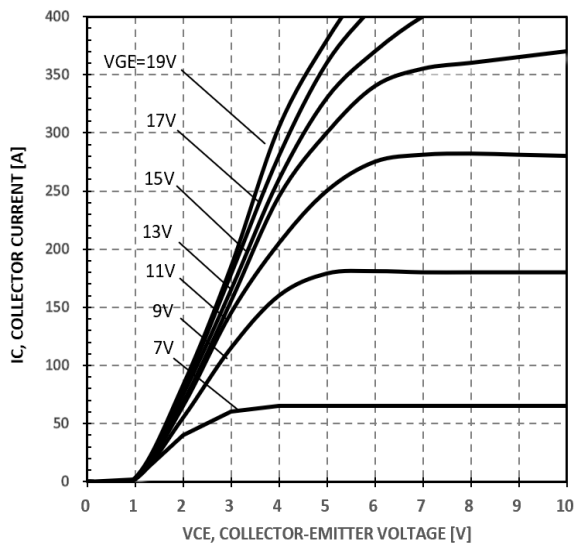


Figure3: typical IGBT output characteristics,
T_J=25°C

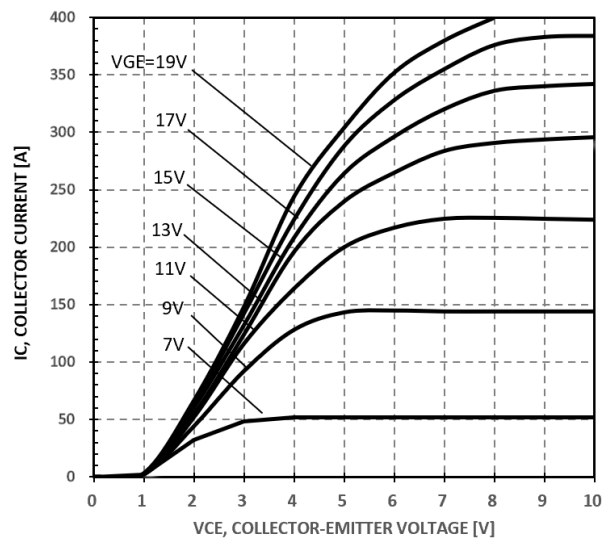


Figure4: typical IGBT output characteristics,
T_J=150°C

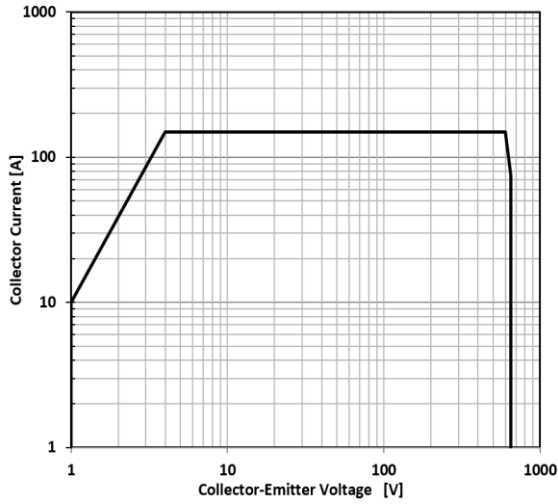


Figure5: reverse bias SOA, $T_J=125^{\circ}\text{C}$, $V_{GE}=15\text{V}$

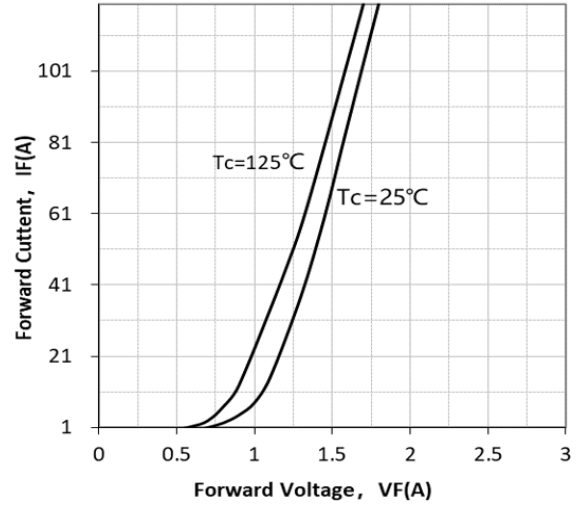


Figure6: typical diode forward characteristic

Figure7: gate threshold voltage

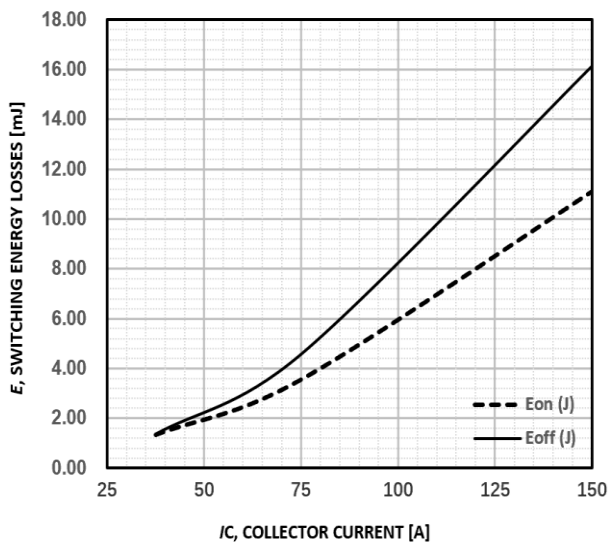


Figure7: typical energy loss VS. I_C , $T_C=25^{\circ}\text{C}$,
 $L=100\mu\text{H}$, $V_{CE}=520\text{V}$, $V_{GE}=15\text{V}$, $R_g=15\Omega$

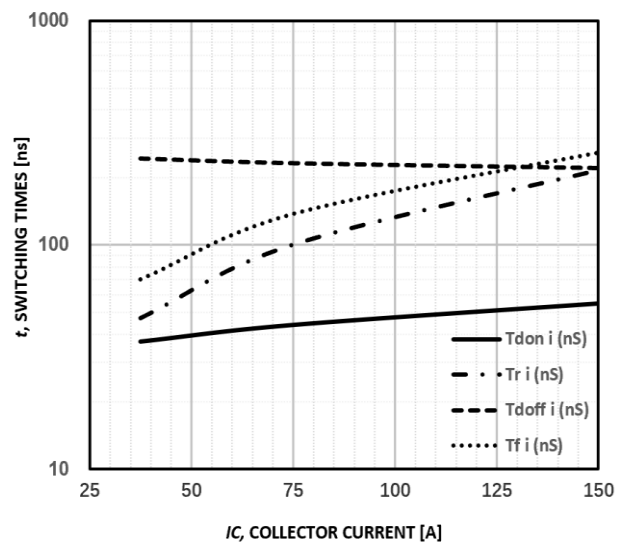


Figure8: typical switching time VS. I_C , $T_C=25^{\circ}\text{C}$,
 $L=100\mu\text{H}$, $V_{CE}=520\text{V}$, $V_{GE}=15\text{V}$, $R_g=15\Omega$

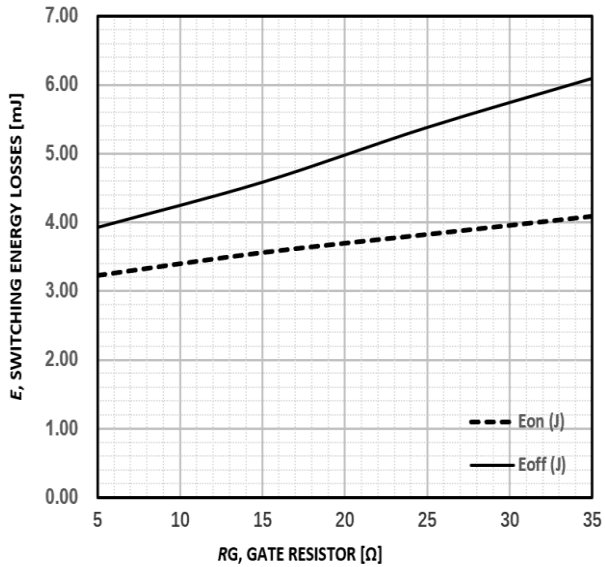


Figure9: typical energy loss VS. Rg,TC=25°C,
L=100uH, VCE=520V, VGE=15V ,IC=75A

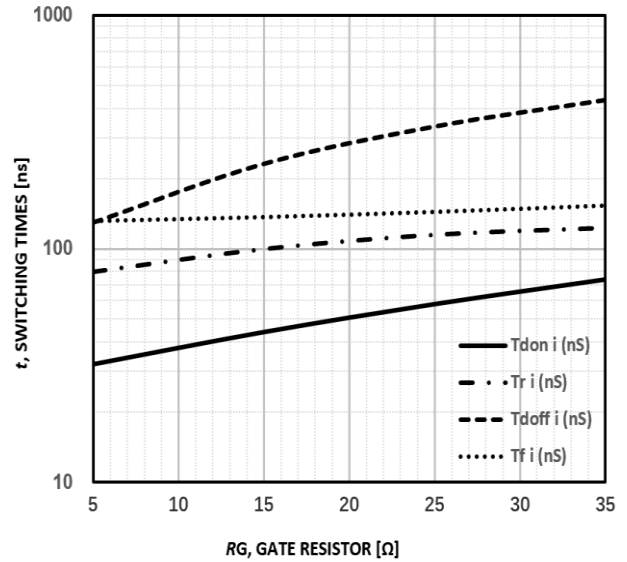


Figure10: typical switching time VS. Rg,TC=25°C,
L=100uH, VCE=520V, VGE=15V ,IC=75A

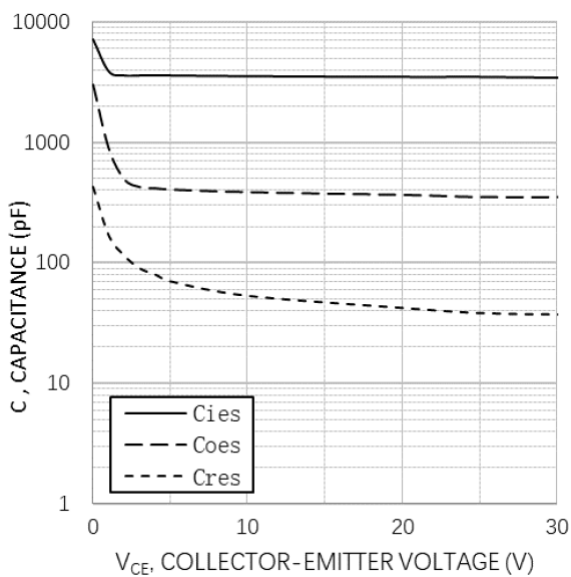


Figure11: typical capacitance VS. VCE,
VGE=0V, f=100kHz

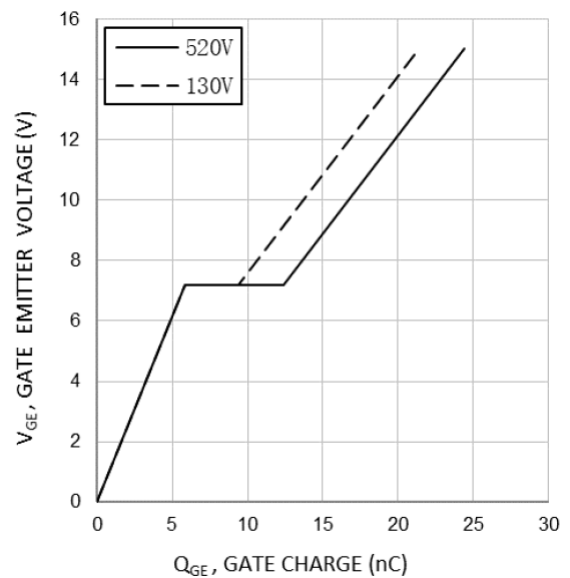
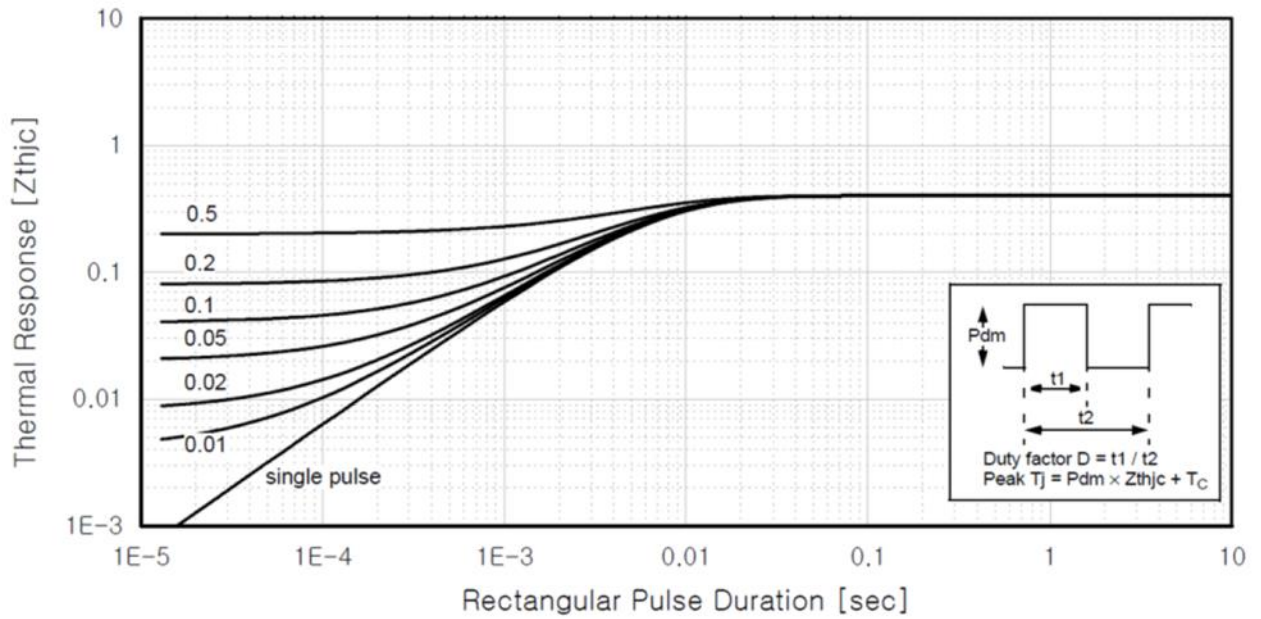


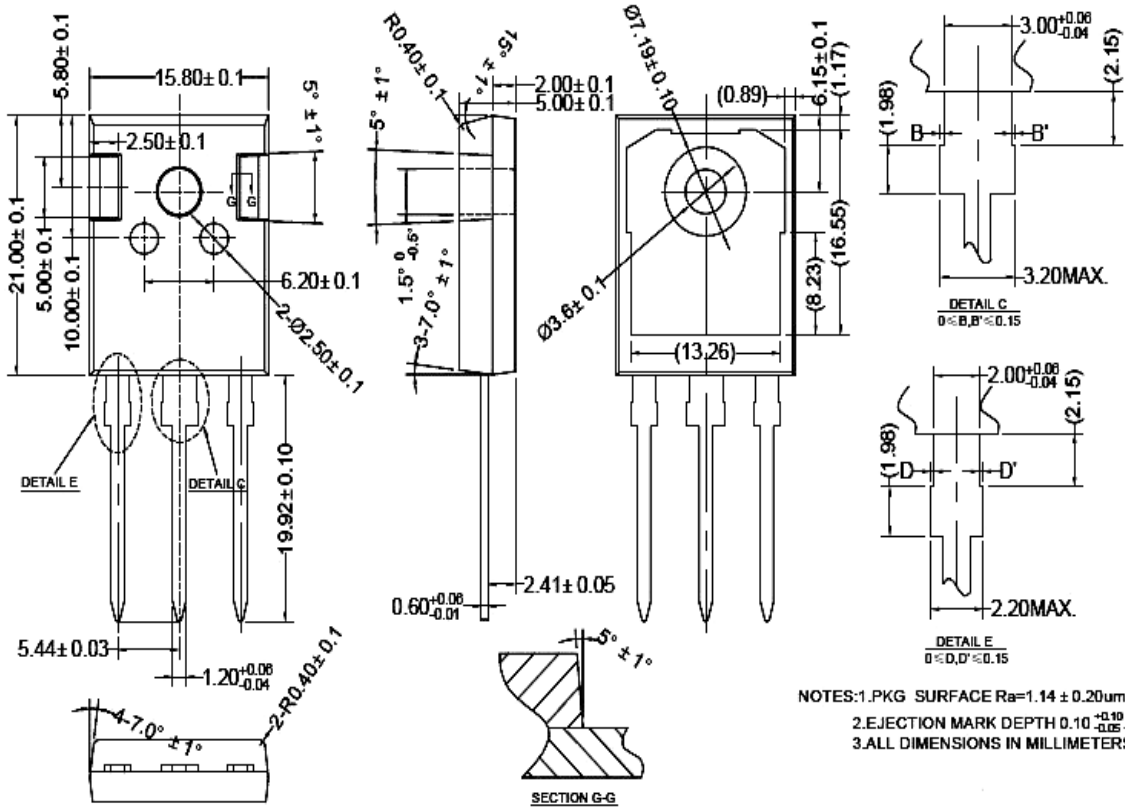
Figure12: typical gate charge VS. VGE, IC=75A

Figure13: normalized transient thermal impedance, junction-to-case

Note1. Duty factor $D=t_1/t_2$ Note2: peak $T_J=PDM \times Z_{thjc} + T_C$



TO247 PACKAGE OUTLINE



NOTES:1.PKG SURFACE Ra=1.14±0.20um.
2.EJECTION MARK DEPTH 0.10^{+0.10}/_{-0.05}
3.ALL DIMENSIONS IN MILLIMETERS.

REVISIONS

公差标注	公差值	表面粗糙度
0	±0.2	Ra3.2~6.3
0.0	±0.1	Ra1.6~3.2
0.00	±0.01	Ra0.8~1.6
0.000	±0.005	Ra0.4~0.8
0.0000	±0.002	Ra0.2~0.4

0≤D,D'≤0.15

NOTES:1.PKG SURFACE Ra=1.14±0.20um.
2.EJECTION MARK DEPTH 0.10^{+0.10}/_{-0.05}
3.ALL DIMENSIONS IN MILLIMETERS.

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